(Legal Instruments Examiner)	Kimnhung Nguyen (Assistant Examiner)		345	CLASS	CROS	345	CLASS		ll ssu		
	er)		98	SUBCI					Issue Classification		
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SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner)	RICHARD H JERDE			SUBCLASS (ONE SUBCLASS PER BLOCK)	E(S)		SUBCLASS		Nguyen, Kimnhung	Application/Control No. 10650930	
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O.G. Print Claim(s)	Total Claims Allowed:						NON-CLAIMED	INTERNATIONAL CLASSIFICATION		Applicant(s)/Patent under Reexamination KOYAMA ET AL.	
O.G. Print Figure 1	Allowed:						AIMED	Ž		tion	

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